

**Search Notes**

Application/Control No.

10/520,422

Examiner

Hoai-An D. Nguyen

Applicant(s)/Patent under  
Reexamination

DAVIES, MARK IAN

Art Unit

2858

**SEARCHED**

Class	Subclass	Date	Examiner
324	519, 512	6/8/2006	HADN
324	500, 716	6/8/2006	HADN
324	661, 662	6/8/2006	HADN
324	663, 658	6/8/2006	HADN
324	671, 699	6/8/2006	HADN
324	635, 644	6/8/2006	HADN
324	229, 230	6/8/2006	HADN
73	1.13	6/8/2006	HADN
73	1.79	6/8/2006	HADN
702	85, 97	6/8/2006	HADN
702	158, 170	6/8/2006	HADN
324	601	6/8/2006	HADN
250	251.2	6/11/2006	HADN

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
324	671	6/8/2006	HADN
702	97	6/8/2006	HADN

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
Text search in EAST.	6/8/2006	HADN
Text search in EAST.	6/11/2006	HADN
Text search in EAST.	6/12/2006	HADN
Interference Search History Printout.	6/12/2006	HADN
Consulted with Primary Examiner M. Cygan. No cross-reference given.	6/12/2006	HADN